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	Application No.	Applicant(s)
Notice of Allowability	10/710,488	CHUNG ET AL.
	Examiner	Art Unit
	Shamim Ahmed	1765
The MAILING DATE of this communication apper All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this apport or other appropriate communication GHTS. This application is subject to	plication. If not included will be mailed in due course. THIS
1. This communication is responsive to <u>3/7/06</u> .		
2. ☐ The allowed claim(s) is/are 1-22.		
 Acknowledgment is made of a claim for foreign priority una a) ☐ All b) ☐ Some* c) ☐ None of the: Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" of the priority unapplication of the priority documents have 2. ☐ Copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have 3. ☐ Copies of the priority documents have 3	been received. been received in Application No cuments have been received in this	national stage application from the
noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD-IS NOT EXTENDABLE. 4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF		
INFORMAL PATENT APPLICATION (PTO-152) which give	es reason(s) why the oath or declara	tion is deficient.
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.		
(a) Including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached		
1) hereto or 2) to Paper No./Mail Date		
(b) including changes required by the attached Examiner's Paper No./Mail Date		
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).		
6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s) 1. ☑ Notice of References Cited (PTO-892)	5.	atent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Summary	
3. Information Disclosure Statements (PTO-1449 or PTO/SB/0	Paper No./Mail Dat 8), 7. ☐ Examiner's Amendn	
Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material		ent of Reasons for Allowance
	9.	Shamim Ahmed Primary Examiner Art Unit: 1765

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REASONS FOR ALLOWANCE

1. The following is an examiner's statement of reasons for allowance: The prior art fail to teach an etching process including the step of forming a plurality of microtrenches at the edges of a residual hard mask layer in the exposed region, wherein the residual hard mask layer remains in the exposed region as claimed.

- 2. The closest prior art Tsai et al (6,878,646) teach a process for reducing the critical dimension of a hard mask but fail to teach a process of reducing pattern pitch on a substrate including the steps of etching the hard mask layer using a patterned photoresist layer, while a residual hard mask layer remains in the exposed region and a plurality of micro-trenches are formed at the edges of the residual hard mask layer in the exposed region as claimed.
- 3. Another closest prior art Zheng (USP 6,475,922) teaches the use of a hard mask (230) on a material layer of polysilicon (220) to be etched using a pattern photoresist masking layer (240)(see figures 2A-2C) but fails to teach leaving a portion of hard mask layer in the exposed region (250) in which micro-trenches are formed at the edges or along the sidewall of the residual hard mask layer as claimed.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to Shamim Ahmed whose telephone number is (571) 272-1457. The examiner can normally be reached on M-Thu (7:00-5:30) Every Friday Off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nadine G. Norton can be reached on (571) 272-1465. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Shamim Ahmed Primary Examiner Art Unit 1765

SA May 15, 2006